Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,245	NIHEI ET AL.	
Examiner	Art Unit	
Christopher P. Schwartz	3683	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search Updated	4/14/2006	CPS	
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